Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/764,405	CHEN ET AL.		
Examiner	Art Unit		
Deanna K. Hall	3767		

SEARCHED				
Class	Subclass	Date	Examiner	
604	523	7/18/2007	DKH	
604	96.01	7/19/2007	DKH	
604	103	7/20/2007	DKH	
604	103.05	7/20/2007	DKH	
604	103.06	7/20/2007	DKH	
604	915	7/20/2007	DKH	
606	191	7/20/2007	DKH	
606	192	7/20/2007	DKH	
606	194	7/20/2007	DKH	
606	108	7/20/2007	DKH	
428	35.2	7/20/2007	DKH	
428	35.7	7/20/2007	DKH	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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DATE	EXMR
7/18/2007	DKH
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7/20/2007	DKH
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